



HID GLOBAL CORPORATION TEST REPORT

FOR THE

6125BXD MULTICLASS RP40 READER

FCC PART 15 SUBPART C SECTIONS 15.207, 15.209 & 15.225 AND RSS-210

COMPLIANCE

DATE OF ISSUE: MARCH 15, 2007

PREPARED FOR:

PREPARED BY:

HID Global Corporation 9292 Jeromino Road Irvine, CA 92618-1905

P.O. No.: 11007580 W.O. No.: 85597 Mary Ellen Clayton CKC Laboratories, Inc. 5046 Sierra Pines Drive Mariposa, CA 95338

Date of test: January 9-25, 2007

Report No.: FC07-015

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ADMINISTRATIVE INFORMATION

DATE OF TEST: January 9-25, 2007

DATE OF RECEIPT: January 9, 2007

MANUFACTURER: HID Global Corporation 9292 Jeromino Road Irvine, CA 92618-1905

REPRESENTATIVE: Mat Aschenberg

TEST LOCATION: CKC Laboratories, Inc. 5046 Sierra Pines Drive Mariposa, CA 95338

TEST METHOD: FCC Part 15 Subpart C Sections 15.207, 15.209, 15.225, RSS-210 and RSS GEN

PURPOSE OF TEST: To demonstrate the compliance of the 6125BxD multiCLASS RP40 Reader with the requirements for FCC Part 15 Subpart C Sections 15.207, 15.209, 15.225 and RSS-210 devices.

APPROVALS

Steve Behm, Director of Engineering Services

QUALITY ASSURANCE:

Joyce Walker, Quality Assurance Administrative Manager

TEST PERSONNEL:

LW:

Mike Wilkinson, EMC Engineer/Lab Manager



Canadian	Canadian	FCC	FCC	Test Description
Standard	Section	Standard	Section	_
RSS 210	5.5	47CFR	15.203	Antenna Connector Requirements
RSS 210	6.2.1	47CFR	15.209	General Radiated Emissions Requirement
RSS 210	6.2.2(e)	47CFR	15.225(a)*	Fundamental Requirements
RSS 210	6.2.2(e)	NA	NA	±150kHz to ±450kHz Emissions Requirement
RSS 210	6.2.2(e)	47CFR	15.225(b)*	Out of band emissions
RSS 210	6.2.2(e)	47CFR	15.225(c)*	Carrier Stability
RSS 210	6.3	47CFR	15.205	Restricted Bands of Operation
RSS 210	6.4	47CFR	15.215(c)	Frequency Stability Recommendation
RSS 210	6.5	47CFR	15.35(c)	Pulsed Operation
RSS 210	6.6	47CFR	15.207	AC Mains Conducted Emissions Requirement
	IC 3082A-1		784962	Site File No.

FCC TO CANADA STANDARD CORRELATION MATRIX

* Indicates that FCC Requirements are more stringent than the Canadian Equivalent.

CONDITIONS FOR COMPLIANCE

No modifications to the EUT were necessary to comply.

FCC 15.33(a) Frequency Ranges Tested

15.207 Conducted Emissions: 150 kHz – 30 MHz 15.209 Radiated Emissions: 9 kHz – 1 GHz

FCC SECTION 15.35: ANALYZER BANDWIDTH SETTINGS PER FREQUENCY RANGE									
TEST BEGINNING FREQUENCY ENDING FREQUENCY BANDWIDTH SETTING									
CONDUCTED EMISSIONS	150 kHz	30 MHz	9 kHz						
RADIATED EMISSIONS	9 kHz	150 kHz	200 Hz						
RADIATED EMISSIONS	150 kHz	30 MHz	9 kHz						
RADIATED EMISSIONS	30 MHz	1000 MHz	120 kHz						

FCC 15.203 Antenna Requirements

The antenna is an integral part of the EUT and is non-removable; therefore the EUT complies with Section 15.203 of the FCC rules.

EUT Operating Frequency

The EUT was operating at 13.56MHz & 125kHz.

Temperature and Humidity During Testing

The temperature during testing was within $+15^{\circ}$ C and $+35^{\circ}$ C. The relative humidity was between 20% and 75%.



EQUIPMENT UNDER TEST (EUT) DESCRIPTION

The customer declares the EUT tested by CKC Laboratories was representative of a production unit. The reader includes a 3127A Indala Prox Expansion Module.

The following model was tested by CKC Laboratories: 6125xxDxx iCLASS RP40

(Since the time of testing the manufacturer has chosen to use the following model name in its place. Any differences between the names does not affect their EMC characteristics and therefore complies to the level of testing equivalent to the tested model name shown on the data sheets: **6125BxD multiCLASS RP40 Reader**

EQUIPMENT UNDER TEST

multiCLASS RP40 Reader

Manuf:	HID Global Corporation
Model:	6125BxD
Serial:	010907
FCC ID:	pending

PERIPHERAL DEVICES

The EUT was tested with the following peripheral device(s): <u>DC Power Supply</u> Manuf: Topward Electric Instruments Co., Ltd.

Model: TPS-2000 Serial: 920035



REPORT OF EMISSIONS MEASUREMENTS

TESTING PARAMETERS

The cables were routed consistent with the typical application by varying the configuration of the test sample. Interface cables were connected to the available ports of the test unit. The effect of varying the position of the cables was investigated to find the configuration that produced maximum emissions. Cables were of the type and length specified in the individual requirements. The length of cable that produced maximum emissions was selected.

The equipment under test (EUT) was set up in a manner that represented its normal use, as shown in the setup photographs. Any special conditions required for the EUT to operate normally are identified in the comments that accompany the emissions tables.

The emissions data was taken with a spectrum analyzer or receiver. Incorporating the applicable correction factors for distance, antenna, cable loss and amplifier gain, the data was reduced as shown in the table below. The corrected data was then compared to the applicable emission limits to determine compliance. Preliminary and final measurements were taken in order to ensure that all emissions from the EUT were found and maximized.

CORRECTION FACTORS

The basic spectrum analyzer reading was converted using correction factors as shown in the highest emissions readings in the tables. For radiated emissions in $dB\mu V/m$, the spectrum analyzer reading in $dB\mu V$ was corrected by using the following formula. This reading was then compared to the applicable specification limit to determine compliance.

	SAMPLE CALCULATIONS								
	Meter reading	(dBµV)							
+	Antenna Factor	(dB)							
+	Cable Loss	(dB)							
-	Distance Correction	(dB)							
-	Preamplifier Gain	(dB)							
=	Corrected Reading	$(dB\mu V/m)$							



TEST INSTRUMENTATION AND ANALYZER SETTINGS

The test instrumentation and equipment listed were used to collect the emissions data. A spectrum analyzer or receiver was used for all measurements. The following table shows the measuring equipment bandwidth settings that were used in designated frequency bands. For testing emissions, an appropriate reference level and a vertical scale size of 10 dB per division were used. When conducted emissions testing was performed, a 10 dB external attenuator was used with internal offset correction in the analyzer.

MEASURING EQUIPMENT BANDWIDTH SETTINGS PER FREQUENCY RANGE								
TEST	BEGINNING FREQUENCY	ENDING FREQUENCY	BANDWIDTH SETTING					
CONDUCTED EMISSIONS	150 kHz	30 MHz	9 kHz					
RADIATED EMISSIONS	30 MHz	1000 MHz	120 kHz					
RADIATED EMISSIONS	1000 MHz	>1 GHz	1 MHz					

SPECTRUM ANALYZER/RECEIVER DETECTOR FUNCTIONS

The notes that accompany the measurements contained in the emissions tables indicate the type of detector function used to obtain the given readings. Unless otherwise noted, all readings were made in the "Peak" mode. Whenever a "Quasi-Peak" or "Average" reading is listed as one of the highest readings, this is indicated as a "Q" or an "A" in the appropriate table. The following paragraphs describe in more detail the detector functions and when they were used to obtain the emissions data.

Peak

In this mode, the spectrum analyzer/receiver readings were recorded all emissions at their peak value as the frequency band selected was scanned. By combining this function with another feature of the measuring device called "peak hold," the measuring device had the ability to measure transients or low duty cycle transient emission peak levels. In this mode the measuring device made a slow scan across the frequency band selected and measured the peak emission value found at each frequency across the band.

Quasi-Peak

When the true peak values exceeded or were within 2 dB of the specification limit, quasi-peak measurements were taken using the quasi-peak detector.

<u>Average</u>

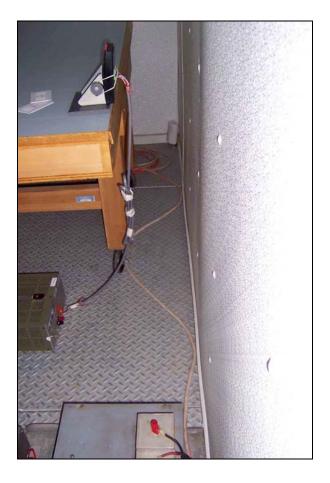
For certain frequencies, average measurements may be made using the spectrum analyzer/receiver. To make these measurements, the test engineer reduces the video bandwidth on the measuring device until the modulation of the signal is filtered out. At this point the measuring device is set into the linear mode and the scan time is reduced.



FCC 15.207 CONDUCTED EMISSIONS

Test Setup Photos





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Test Data Sheets

Test Location:	CKC Laboratories	•4933 Sierra Pines Dr.	• Mariposa, CA 95338	• 1-800-500-4EMC (4362)
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Customer:	HID Global Corporation		
Specification:	FCC 15.207 - AVE		
Work Order #:	85597	Date:	1/10/2007
Test Type:	Conducted Emissions	Time:	3:52:14 PM
Equipment:	iCLASS Reader	Sequence#:	9
Manufacturer:	HID Global Corporation	Tested By:	Mike Wilkinson
Model:	6125xxDxx iCLASS RP40		120V 60Hz
S/N:	010907		

Test Equipment:

Function	S/N	Calibration Date	Cal Due Date	Asset #
Agilent E4446A SA	US44300407	01/12/2005	01/12/2007	02660
150kHz HP Filter TTE	G7754	03/09/2006	03/09/2008	02608
LISN, 8028-50-TS-24-BNC	8379276, 280	06/03/2005	06/03/2007	1248 & 1249

Equipment Under Test (* = EUT):									
Function	Manufacturer	Model #	S/N						
iCLASS Reader*	HID Global Corporation	6125xxDxx iCLASS RP40	010907						
Support Devices:									
Function	Manufacturer	Model #	S/N						
DC Power Supply	Topward Electric	TPS-2000	920035						
	Instruments Co., Ltd.								

Test Conditions / Notes:

Equipment is an iCLASS Reader operating on a frequency of 13.56MHz & 125kHz. The EUT is mounted vertically on a support structure to simulate normal installation. DC power supply is bonded to ground. Frequency Range Investigated: 150kHz - 30MHz. Temperature: 21°C, Relative Humidity: 35%.

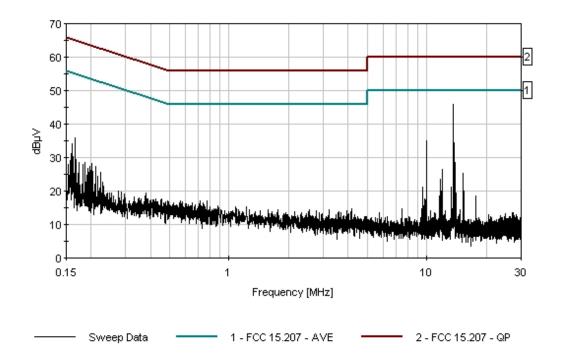
T1=LISN Insertion Loss s/n276	T2=Filter 150kHz HP AN02608
T3=Cable - Site D LISN 100k-30M	

Measur	ement Data:	Re	ading lis	ted by ma	argin.			Test Lead	d: Black		
#	Freq	Rdng	T1	T2	T3		Dist	Corr	Spec	Margin	Polar
	MHz	dBµV	dB	dB	dB	dB	Table	dBµV	dBµV	dB	Ant
1	13.561M	34.3	+0.5	+0.1	+10.9		+0.0	45.8	50.0	-4.2	Black
2	13.564M	33.1	+0.5	+0.1	+10.9		+0.0	44.6	50.0	-5.4	Black
3	13.557M	30.1	+0.5	+0.1	+10.9		+0.0	41.6	50.0	-8.4	Black
4	13.567M	26.1	+0.5	+0.1	+10.9		+0.0	37.6	50.0	-12.4	Black
5	9.978M	23.5	+0.5	+0.1	+10.8		+0.0	34.9	50.0	-15.1	Black
6	13.772M	22.8	+0.5	+0.1	+10.9		+0.0	34.3	50.0	-15.7	Black



7	13.775M	21.8	+0.5	+0.1	+10.9	+0.0	33.3	50.0	-16.7	Black
8	13.769M	21.6	+0.5	+0.1	+10.9	+0.0	33.1	50.0	-16.9	Black
9	13.554M	21.5	+0.5	+0.1	+10.9	+0.0	33.0	50.0	-17.0	Black
10	13.570M	20.2	+0.5	+0.1	+10.9	+0.0	31.7	50.0	-18.3	Black
11	165.999k	22.4	+0.4	+1.3	+11.7	+0.0	35.8	55.2	-19.4	Black
12	13.778M	19.0	+0.5	+0.1	+10.9	+0.0	30.5	50.0	-19.5	Black
13	13.694M	18.8	+0.5	+0.1	+10.9	+0.0	30.3	50.0	-19.7	Black
14	13.691M	18.6	+0.5	+0.1	+10.9	+0.0	30.1	50.0	-19.9	Black
15	13.697M	17.9	+0.5	+0.1	+10.9	+0.0	29.4	50.0	-20.6	Black

CKC Laboratories_Date: 1/10/2007_Time: 3:52:14 PM_HID Global VVO#: 85597 FCC 15:207 - AVE_Test Lead: Black 120V 60Hz Sequence#: 9 HID Global M/N 3125xxDxx iCLASS RP40





Test Location: CKC Laboratories •4933 Sierra Pines Dr. • Mariposa, CA 95338 • 1-800-500-4EMC (4362)

Customer:	HID Global Corporation		
Specification:	FCC 15.207 - AVE		
Work Order #:	85597	Date:	1/10/2007
Test Type:	Conducted Emissions	Time:	15:51:25
Equipment:	iCLASS Reader	Sequence#:	8
Manufacturer:	HID Global Corporation	Tested By:	Mike Wilkinson
Model:	6125xxDxx iCLASS RP40		120V 60Hz
S/N:	010907		

Test Equipment:

Function	S/N	Calibration Date	Cal Due Date	Asset #
Agilent E4446A SA	US44300407	01/12/2005	01/12/2007	02660
150kHz HP Filter TTE	G7754	03/09/2006	03/09/2008	02608
LISN, 8028-50-TS-24-BNC	8379276, 280	06/03/2005	06/03/2007	1248 & 1249

Equipment	Under	Test	(* =	EUT):
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Function	Manufacturer	Model #	S/N
iCLASS Reader*	HID Global Corporation	6125xxDxx iCLASS RP40	010907

Support Devices:

Support Derices.				-
Function	Manufacturer	Model #	S/N	
DC Power Supply	Topward Electric	TPS-2000	920035	
	Instruments Co., Ltd.			

Test Conditions / Notes:

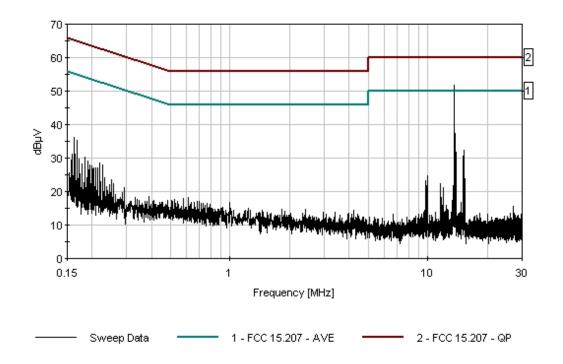
Equipment is an iCLASS Reader operating on a frequency of 13.56MHz & 125kHz. The EUT is mounted vertically on a support structure to simulate normal installation. DC power supply is bonded to ground. Frequency Range Investigated: 150kHz - 30MHz. Temperature: 21°C, Relative Humidity: 35%.

T1=LISN Insertion Loss s/n280	T2=Filter 150kHz HP AN02608
T3=Cable - Site D LISN 100k-30M	

Measu	rement Data:	Re	eading lis	ted by ma	argin.			Test Lead	d: White		
#	Freq	Rdng	T1	T2	T3		Dist	Corr	Spec	Margin	Polar
	MHz	dBµV	dB	dB	dB	dB	Table	dBµV	dBµV	dB	Ant
1	15.240M	21.4	+0.4	+0.1	+10.8		+0.0	32.7	50.0	-17.3	White
2	9.980M	20.6	+0.4	+0.1	+10.8		+0.0	31.9	50.0	-18.1	White
3	13.561M	20.5	+0.4	+0.1	+10.9		+0.0	31.9	50.0	-18.1	White
	Ave										
٨	13.561M	40.5	+0.4	+0.1	+10.9		+0.0	51.9	50.0	+1.9	White
5	11.980M	16.9	+0.4	+0.1	+10.9		+0.0	28.3	50.0	-21.7	White
6	11.760M	12.3	+0.4	+0.1	+10.9		+0.0	23.7	50.0	-26.3	White
7	14.180M	11.2	+0.4	+0.1	+10.9		+0.0	22.6	50.0	-27.4	White
8	350.000k	7.3	+0.3	+0.1	+12.0		+0.0	19.7	49.0	-29.3	White



CKC Laboratories_Date: 1/10/2007_Time: 15:51:25_HID Global WO#: 85597 FCC 15:207 - AVE_Test Lead: White 120V 60Hz Sequence#: 8 HID Global M/N 3125xxDxx iCLASS RP40





FCC 15.209 RADIATED EMISSIONS

Test Setup Photos







Test Data Sheets

Test Location:

Customer:	HID Global Corporation		
Specification:	FCC 15.209		
Work Order #:	85597	Date:	1/15/2007
Test Type:	Radiated Scan	Time:	16:19:58
Equipment:	iCLASS Reader	Sequence#:	22
Manufacturer:	HID Global Corporation	Tested By:	Mike Wilkinson
Model:	6125xxDxx iCLASS RP40		
S/N:	010907		

Test Equipment:

Function	S/N	Calibration Date	Cal Due Date	Asset #
Agilent E4446A SA	US44300407	01/03/2007	01/03/2009	02660
EMCO Loop Antenna	1074	05/13/2005	05/13/2007	00226

CKC Laboratories •4933 Sierra Pines Dr. • Mariposa, CA 95338 • 1-800-500-4EMC (4362)

<u>Equipment Under Test (* :</u>	= EUT):		
Function	Manufacturer	Model #	S/N
iCLASS Reader*	HID Global Corporation	6125xxDxx iCLASS RP40	010907
Support Devices:			
Function	Manufacturer	Model #	S/N
DC Power Supply	Topward Electric	TPS-2000	920035
	Instruments Co., Ltd.		

Test Conditions / Notes:

Equipment is an iCLASS Reader operating on a frequency of 13.56MHz and 125kHz The EUT is mounted vertically on a support structure to simulate normal installation. DC power supply is bonded to ground. Test data is corrected for proper test distance using 40dB per decade correction factor in accordance with 15.31. Frequency Range Investigated: Carrier. Relative Humidity: 35%.

T1=Cable - Site D 10m 9k-1G	T2=Mag Loop - AN 00226 - 9kHz-30M
T3=15.31 10m 40dB/Dec Correction	

Measurement Data:		Re	ading lis	ted by ma	argin.	Test Distance: 10 Meters						
#	ŧ	Freq	Rdng	T1	T2	T3		Dist	Corr	Spec	Margin	Polar
		MHz	dBµV	dB	dB	dB	dB	Table	$dB\mu V/m$	$dB\mu V/m$	dB	Ant
	1	125.052k	44.0	+0.2	+10.2	-60.0		+0.0	-5.6	25.7	-31.3	Vert
	2	125.096k	36.4	+0.2	+10.2	-60.0		+0.0	-13.2	25.7	-38.9	Horiz



Test Location: CKC Laboratories •4933 Sierra Pines Dr. • Mariposa, CA 95338 • 1-800-500-4EMC (4362)	Test Location:	CKC Laboratories	•4933 Sierra Pines Dr.	• Mariposa, CA 95338	• 1-800-500-4EMC (4362)
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Customer: Specification:	HID Global Corporation FCC 15.209		
Work Order #:	85597	Date:	1/15/2007
Test Type:	Radiated Scan	Time:	16:42:11
Equipment:	iCLASS Reader	Sequence#:	23
Manufacturer:	HID Global Corporation	Tested By:	Mike Wilkinson
Model:	6125xxDxx iCLASS RP40		
S/N:	010907		

Test Equipment:

Function	S/N	Calibration Date	Cal Due Date	Asset #
Agilent E4446A SA	US44300407	01/12/2005	01/12/2007	02660
EMCO Loop Antenna	1074	05/13/2005	05/13/2007	00226

Equipment Under Test (* = EUT):								
Function	Manufacturer	Model #	S/N					
iCLASS Reader*	HID Global Corporation	6125xxDxx iCLASS RP40	010907					
Support Devices:								

Function	Manufacturer	Model #	S/N	
DC Power Supply	Topward Electric Instruments Co., Ltd.	TPS-2000	920035	

Test Conditions / Notes:

Equipment is an iCLASS Reader operating on a frequency of 13.56MHz and 125kHz The EUT is mounted vertically on a support structure to simulate normal installation. DC power supply is bonded to ground. Test data is corrected for proper test distance using 40dB per decade correction factor in accordance with 15.31. Frequency Range Investigated: 9kHz to 30MHz. Relative Humidity: 35%.

T1=Cable - Site D 10m 9k-1G	T2=Mag Loop - AN 00226 - 9kHz-30M
T3=15.31 10m 40dB/Dec Correction	

Measurement Data:		Re	eading lis	ted by ma	argin.	Test Distance: 10 Meters					
#	Freq	Rdng	T1	T2	T3		Dist	Corr	Spec	Margin	Polar
	MHz	dBµV	dB	dB	dB	dB	Table	$dB\mu V/m$	$dB\mu V/m$	dB	Ant
1	27.122M	21.8	+1.4	+6.6	-20.0		+0.0	9.8	29.5	-19.7	Horiz
2	2 250.026k	46.6	+0.2	+10.2	-60.0		+0.0	-3.0	19.6	-22.6	Vert
3	3 27.122M	14.2	+1.4	+6.6	-20.0		+0.0	2.2	29.5	-27.3	Vert
2	250.096k	39.4	+0.2	+10.2	-60.0		+0.0	-10.2	19.6	-29.8	Horiz



FCC 15.225 RADIATED EMISSIONS

Test Setup Photos







Test Data Sheets

Test Location: CKC Laboratorie	•4933 Sierra Pines Dr.	• Mariposa, CA 95338	• 1-800-500-4EMC (4362)
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Customer:	HID Global Corporation		
Specification:	15.225/15.209		
Work Order #:	85597	Date:	1/10/2007
Test Type:	Radiated Scan	Time:	14:25:44
Equipment:	iCLASS Reader	Sequence#:	4
Manufacturer:	HID Global Corporation	Tested By:	Mike Wilkinson
Model:	6125xxDxx iCLASS RP40		
S/N:	010907		

Test Equipment:

Function	S/N	Calibration Date	Cal Due Date	Asset #
Agilent E4446A SA	US44300407	01/12/2005	01/12/2007	02660
Chase CBL6111C Bilog	2456	06/07/2005	06/07/2007	01991
HP 8447D Preamp	1937A02604	03/11/2005	03/11/2007	00099

Equipment Under Test (* = EUT):							
Function	Manufacturer	Model #	S/N				
iCLASS Reader*	HID Global Corporation	6125xxDxx iCLASS RP40	010907				
Support Devices:							
Function	Manufacturer	Model #	S/N				
DC Power Supply	Topward Electric	TPS-2000	920035				
	Instruments Co., Ltd.						

Test Conditions / Notes:

Equipment is an iCLASS Reader operating on a frequency of 13.56MHz & 125kHz. The EUT is mounted vertically on a support structure to simulate normal installation. DC power supply is bonded to ground. Frequency Range Investigated: 30-1000MHz. Temperature: 21°C, Relative Humidity: 35%.

T1=C	able - Site D 10m 9k-1G	T2=Amp - S/N 604
T3=B	ilog Site D	

Meası	rement Data:	Re	eading lis	ted by ma	argin.		Τe	est Distance	e: 10 Meter	rs	
#	Freq	Rdng	T1	T2	T3		Dist	Corr	Spec	Margin	Polar
	MHz	dBµV	dB	dB	dB	dB	Table	$dB\mu V/m$	$dB\mu V/m$	dB	Ant
1	176.301M	40.0	+3.9	-26.7	+8.4		+10.0	35.6	43.5	-7.9	Vert
	QP										
^	176.301M	42.2	+3.9	-26.7	+8.4		+10.0	37.8	43.5	-5.7	Vert
3	54.248M	36.2	+2.0	-26.8	+7.3		+10.0	28.7	40.0	-11.3	Vert
4	122.053M	32.7	+3.3	-26.7	+11.0		+10.0	30.3	43.5	-13.2	Vert
5	325.492M	29.4	+5.6	-26.4	+13.5		+10.0	32.1	46.0	-13.9	Vert
6	149.193M	31.8	+3.6	-26.7	+10.4		+10.0	29.1	43.5	-14.4	Vert



7	135.616M	30.5	+3.4	-26.7	+11.0	+10.0	28.2	43.5	-15.3	Vert
8	230.544M	30.3	+4.7	-26.2	+10.7	+10.0	29.5	46.0	-16.5	Vert
9	311.899M	27.0	+5.5	-26.3	+13.2	+10.0	29.4	46.0	-16.6	Vert
10	311.892M	26.6	+5.5	-26.3	+13.2	+10.0	29.0	46.0	-17.0	Horiz
11	216.984M	30.8	+4.4	-26.3	+9.7	+10.0	28.6	46.0	-17.4	Vert



Test Location:	CKC Laboratories	•4933 Sierra Pines Dr.	 Mariposa, CA 	95338 •	1-800-500-4EMC (4362)
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Customer: Specification:	HID Global Corporation FCC 15.225(a)		
Work Order #:	85597	Date:	1/15/2007
Test Type:	Radiated Scan	Time:	16:02:09
Equipment:	iCLASS Reader	Sequence#:	21
Manufacturer:	HID Global Corporation	Tested By:	Mike Wilkinson
Model:	6125xxDxx iCLASS RP40		
S/N:	010907		
Test Equipment	f• •		

Function	S/N	Calibration Date	Cal Due Date	Asset #
Agilent E4446A SA	US44300407	01/12/2005	01/12/2007	02660
EMCO Loop Antenna	1074	05/13/2005	05/13/2007	00226

Equipment Under Test (* = EUT):					
Function	Manufacturer	Model #	S/N		
iCLASS Reader*	HID Global Corporation	6125xxDxx iCLASS RP40	010907		
Support Devices:					

Function	Manufacturer	Model #	S/N
DC Power Supply	Topward Electric	TPS-2000	920035
	Instruments Co., Ltd.		

Test Conditions / Notes:

Equipment is an iCLASS Reader operating on a frequency of 13.56MHz and 125kHz The EUT is mounted vertically on a support structure to simulate normal installation. DC power supply is bonded to ground. Test data is corrected for proper test distance using 40dB per decade correction factor in accordance with 15.31. Frequency Range Investigated: Carrier. Relative Humidity: 35%.

T1=Cable - Site D 10m 9k-1G	T2=Mag Loop - AN 00226 - 9kHz-30M
T3=15.31 10m 40dB/Dec Correction	

М	leasur	ement Data:	Re	ading lis	ted by ma	argin.		Te	est Distance	e: 10 Meter	rs	
	#	Freq	Rdng	T1	T2	T3		Dist	Corr	Spec	Margin	Polar
		MHz	dBµV	dB	dB	dB	dB	Table	$dB\mu V/m$	$dB\mu V/m$	dB	Ant
	1	13.561M	49.2	+1.0	+9.6	-20.0		+0.0	39.8	84.0	-44.2	Vert
	2	13.561M	48.3	+1.0	+9.6	-20.0		+0.0	38.9	84.0	-45.1	Horiz



FREQUENCY STABILITY

Test Equipment

Description	Asset #	Manufacturer	Model #	Serial #	Cal Date	Cal Due
Spectrum Analyzer	1406	HP	8564E	3623A00539	8/01/06	8/01/08
Temp Chamber	01879	Thermotron	S-1.2 MiniMax	11899	1/24/05	1/24/07
Thermometer	02242	Omega	HH-26K	T-202884	1/18/05	1/18/07
Multimeter	02369	Fluke	8520A		4/25/05	4/25/07

Test Conditions: EUT was placed inside the temperature chamber and was transmitting continuously. SA RBW =1.0 kHz, VBW = 10 kHz, Span = 5 kHz.

Test Setup Photos





Test Data

Customer:	HID Global
WO#:	85597
Test Engineer:	Mike Wilkinson
Operating Voltage:	12 VDC
Frequency Limit:	0.01 %

Temperature Variations

		6125BxxDxx	
		iCLASS RP40	Dev. (MHz)
Channel Frequency:		13.561190	
Temp (C)	Voltage		
-20	12	13.561286	0.00010
-10	12	13.561280	0.00009
0	12	13.561250	0.00006
10	12	13.561255	0.00006
20	12	13.561190	0.00000
30	12	13.561160	0.00003
40	12	13.561120	0.00007
50	12	13.561102	0.00009

Voltage Variations (±15%)

20	10.2	13.561190	0.00000
	- • • -		
20	12	13.561190	0.00000
20	13.8	13.561190	0.00000

Max Deviation (MHz) Max Deviation (%)	0.00010 0.00071		
	PASS		



OCCUPIED BANDWIDTH

Test Equipment

I cot Equipment					
Function	S/N	Calibration Date	Cal Due Date	Asset #	
Agilent E4446A SA	US44300407	01/12/2005	01/12/2007	02660	
EMCO Loop Antenna	1074	05/13/2005	05/13/2007	00226	

Test Setup Photos

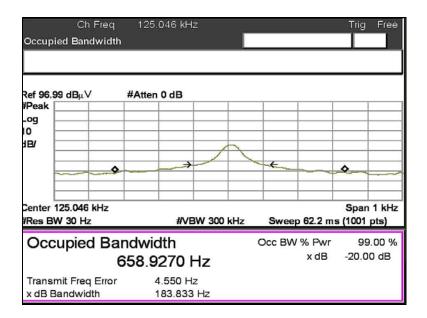


Test Conditions

Equipment is an iCLASS Reader operating on a frequency of 13.56MHz and 125kHz. The EUT is mounted vertically on a support structure to simulate normal installation. DC power supply is bonded to ground.



OCCUPIED BANDWIDTH - 125kHz



OCCUPIED BANDWIDTH - 1356MHz

